

# Search Notes



Application/Control No.

10/616,479

Examiner

Tae H. Yoon

Applicant(s)/Patent under Reexamination

MCCLESKEY ET AL.

Art Unit

1714

## SEARCHED

Class	Subclass	Date	Examiner
106	436	5/21/07	22
528	490		
524	401	12/5/07	22
528	502A		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
524	401	12/06/07	22

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
CAST	5/21/07	22
2nd round Search		
CAST	12/5/07	22